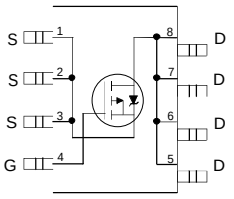
International
IOR Rectifier

PD - 91247D

IRF7406

HEXFET® Power MOSFET

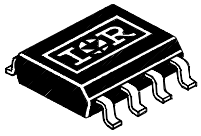
- Generation V Technology
- Ultra Low On-Resistance
- P-Channel Mosfet
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching



Top View

V_{DSS} = -30V

$R_{DS(on)}$ = 0.045Ω


SO-8

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

Absolute Maximum Ratings

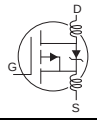
	Parameter	Max.	Units
I_D @ T_A = 25°C	10 Sec. Pulsed Drain Current, V_{GS} @ -10V	-6.7	A
I_D @ T_A = 25°C	Continuous Drain Current, V_{GS} @ -10V	-5.8	
I_D @ T_A = 70°C	Continuous Drain Current, V_{GS} @ -10V	-3.7	
I_{DM}	Pulsed Drain Current ①	-23	
P_D @T_A = 25°C	Power Dissipation	2.5	W
	Linear Derating Factor	0.02	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery dv/dt ②	-5.0	V/ns
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

Thermal Resistance Ratings

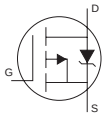
	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient④	–––	50	°C/W

06/12/03

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-30	–––	–––	V	V_{GS} = 0V, ID = -250µA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	–––	-0.020	–––	V/°C	Reference to 25°C, I_D = -1mA
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance	–––	–––	0.045	Ω	V_{GS} = -10V, I_D = -2.8A ③
		–––	–––	0.070		V_{GS} = -4.5V, I_D = -2.4A ③
$V_{GS(th)}$	Gate Threshold Voltage	-1.0	–––	–––	V	V_{DS} = V_{GS}, I_D = -250µA
g_{fs}	Forward Transconductance	3.1	–––	–––	S	V_{DS} = -15V, I_D = -2.8A
I_{DSS}	Drain-to-Source Leakage Current	–––	–––	-1.0	µA	V_{DS} = -24V, V_{GS} = 0V
		–––	–––	-25		V_{DS} = -24V, V_{GS} = 0V, T_J = 125°C
I_{GSS}	Gate-to-Source Forward Leakage	–––	–––	-100	nA	V_{GS} = -20V
	Gate-to-Source Reverse Leakage	–––	–––	100		V_{GS} = 20V
Q_g	Total Gate Charge	–––	–––	59	nC	I_D = -2.8A
Q_{gs}	Gate-to-Source Charge	–––	–––	5.7		V_{DS} = -2.4V
Q_{gd}	Gate-to-Drain ("Miller") Charge	–––	–––	21		V_{GS} = -10V, See Fig. 6 and 12 ③
$t_{d(on)}$	Turn-On Delay Time	–––	16	–––	ns	V_{DD} = -15V
t_r	Rise Time	–––	33	–––		I_D = -2.8A
$t_{d(off)}$	Turn-Off Delay Time	–––	45	–––		R_G = 6.0Ω
t_f	Fall Time	–––	47	–––		R_D = 5.3Ω, See Fig. 10 ③
L_D	Internal Drain Inductance	–––	2.5	–––	nH	Between lead tip and center of die contact 
L_S	Internal Source Inductance	–––	4.0	–––		
C_{iss}	Input Capacitance	–––	1100	–––	pF	V_{GS} = 0V
C_{oss}	Output Capacitance	–––	490	–––		V_{DS} = -25V
C_{rss}	Reverse Transfer Capacitance	–––	220	–––		f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	–––	–––	-3.1	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①	–––	–––	-23		
V_{SD}	Diode Forward Voltage	–––	–––	-1.0	V	T_J = 25°C, I_S = -2.0A, V_{GS} = 0V ③
t_{rr}	Reverse Recovery Time	–––	42	63	ns	T_J = 25°C, I_F = -2.8A
Q_{rr}	Reverse Recovery Charge	–––	64	96	nC	di/dt = 100A/µs ③
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② I_{SD} ≤ -2.8A, di/dt ≤ 90A/µs, V_{DD} ≤ $V_{(BR)DSS}$, T_J ≤ 150°C

③ Pulse width ≤ 300µs; duty cycle ≤ 2%.

④ Surface mounted on FR-4 board, t ≤ 10sec.

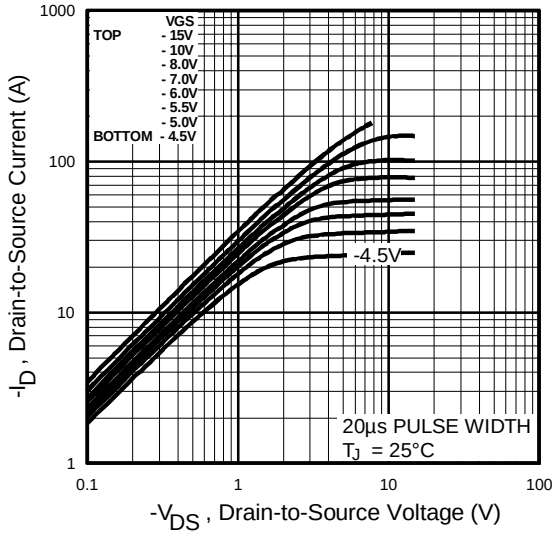


Fig 1. Typical Output Characteristics

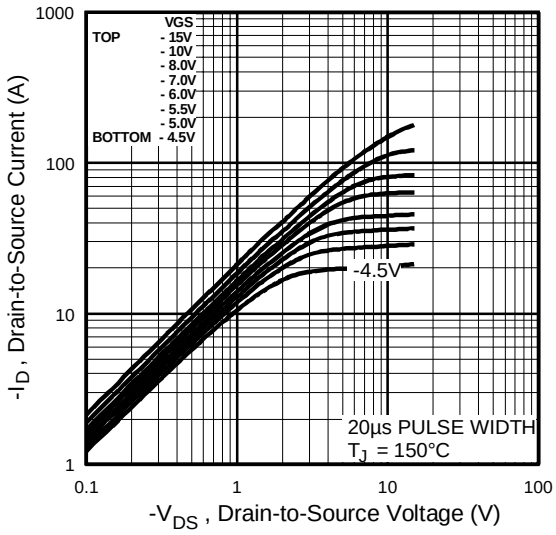


Fig 2. Typical Output Characteristics

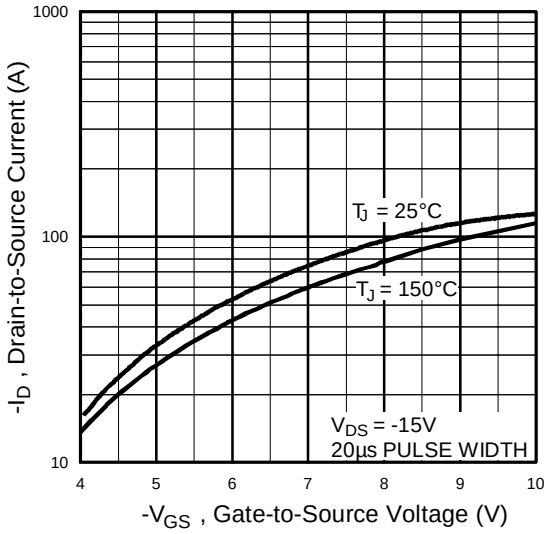


Fig 3. Typical Transfer Characteristics

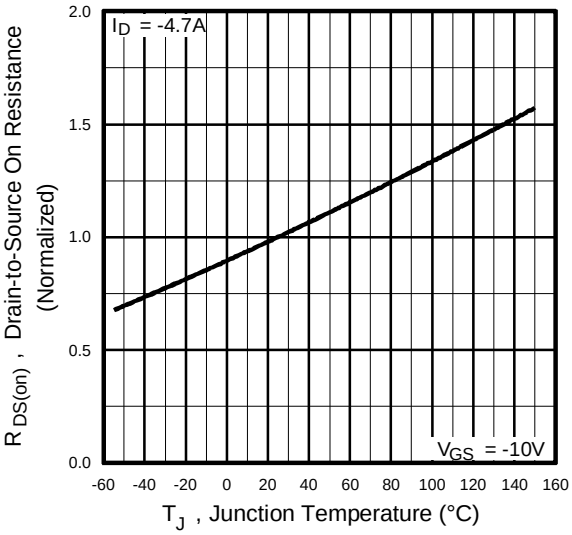


Fig 4. Normalized On-Resistance Vs. Temperature

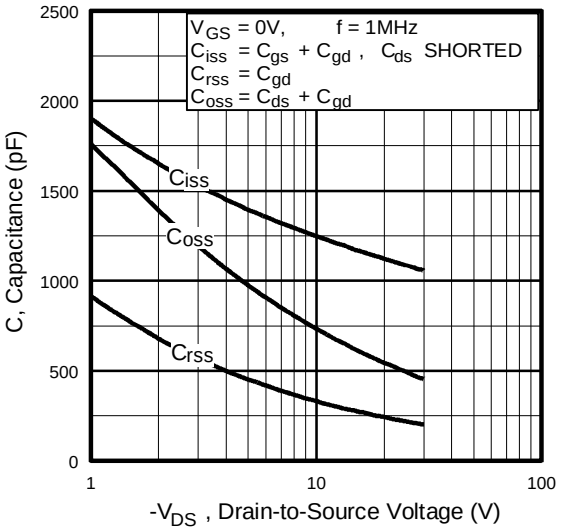


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

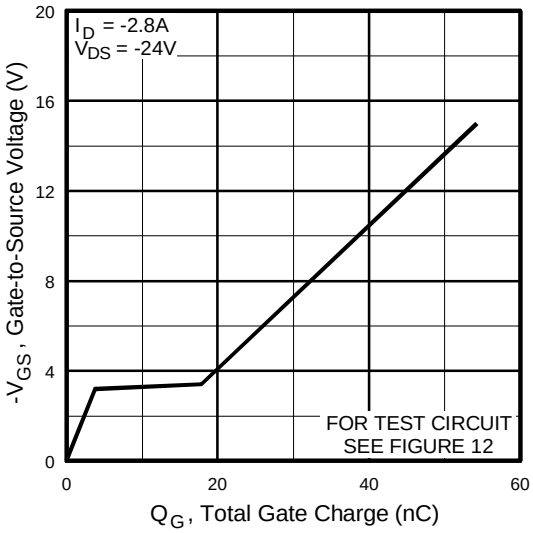


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

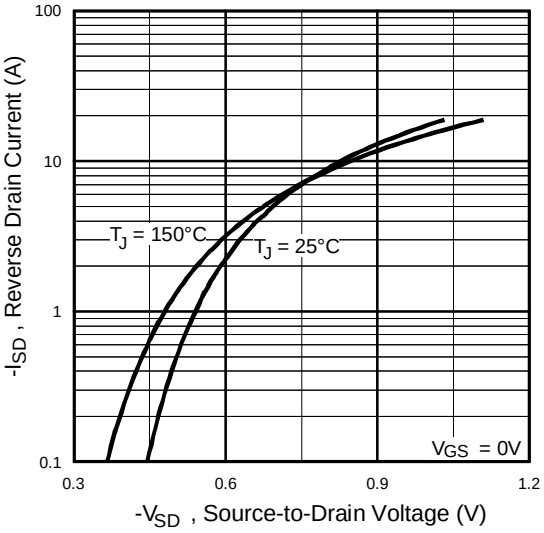


Fig 7. Typical Source-Drain Diode Forward Voltage

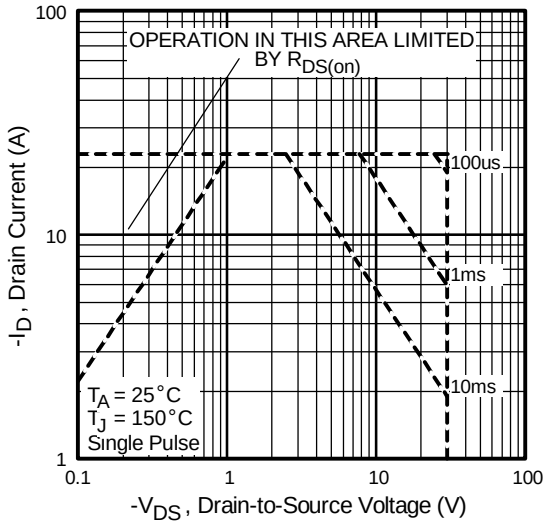


Fig 8. Maximum Safe Operating Area

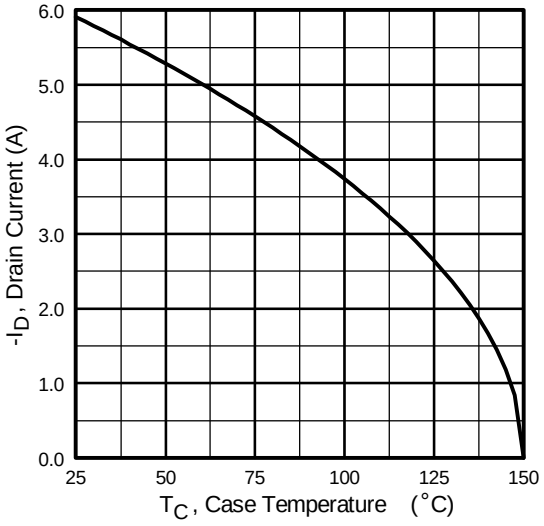


Fig 9. Maximum Drain Current Vs. Ambient Temperature

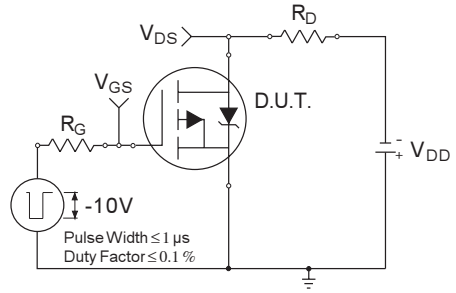


Fig 10a. Switching Time Test Circuit

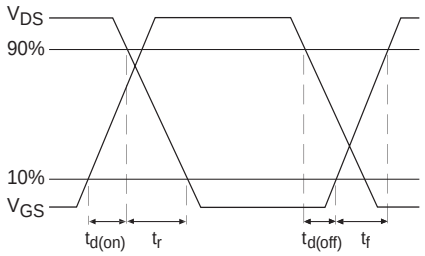
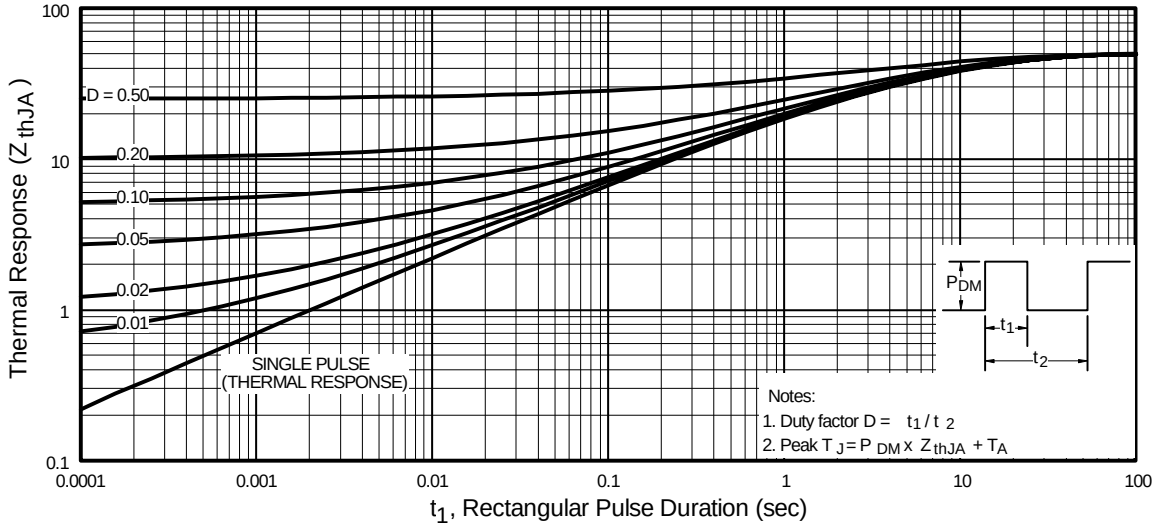


Fig 10b. Switching Time Waveforms



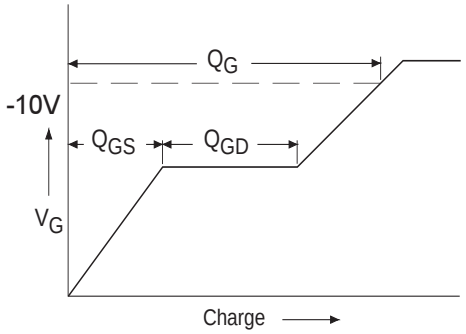


Fig 12a. Basic Gate Charge Waveform

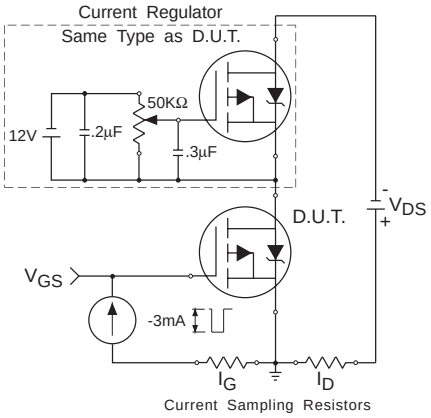
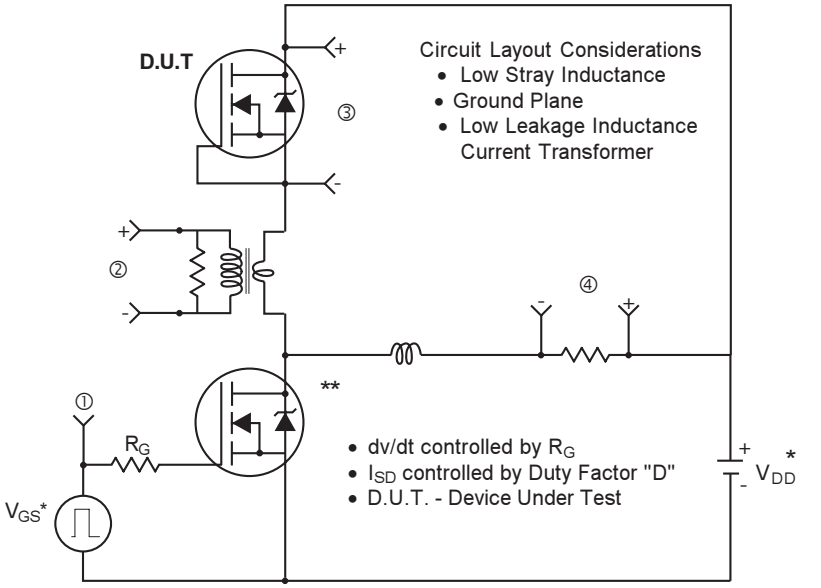
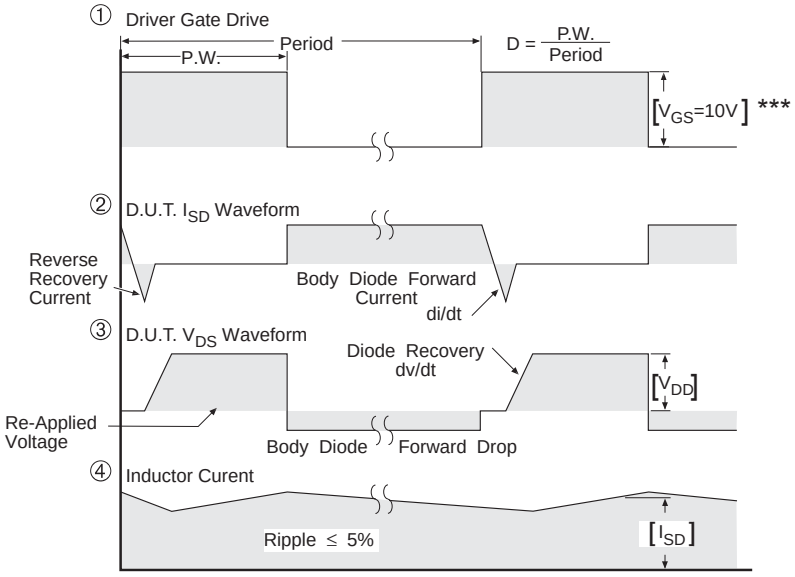


Fig 12b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity for P-Channel
** Use P-Channel Driver for P-Channel Measurements



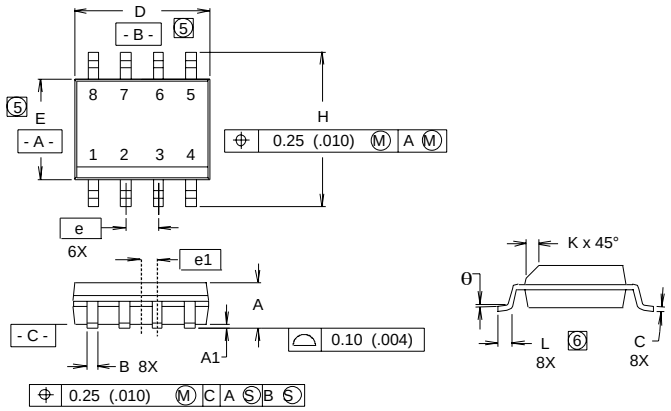
*** V_{GS} = 5.0V for Logic Level and 3V Drive Devices

Fig 13. For P-Channel HEXFETS

Package Outline

SO-8 Outline

Dimensions are shown in millimeters (inches)



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
B	.014	.018	0.36	0.46
C	.0075	.0098	0.19	0.25
D	.189	.196	4.80	4.98
E	.150	.157	3.81	3.99
e	.050 BASIC		1.27 BASIC	
e1	.025 BASIC		0.635 BASIC	
H	.2284	.2440	5.80	6.20
K	.011	.019	0.28	0.48
L	0.16	.050	0.41	1.27
θ	0°	8°	0°	8°

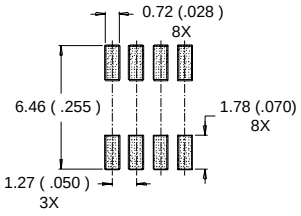
NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1982.
2. CONTROLLING DIMENSION : INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.

5 DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS
MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.006).

6 DIMENSIONS IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE..

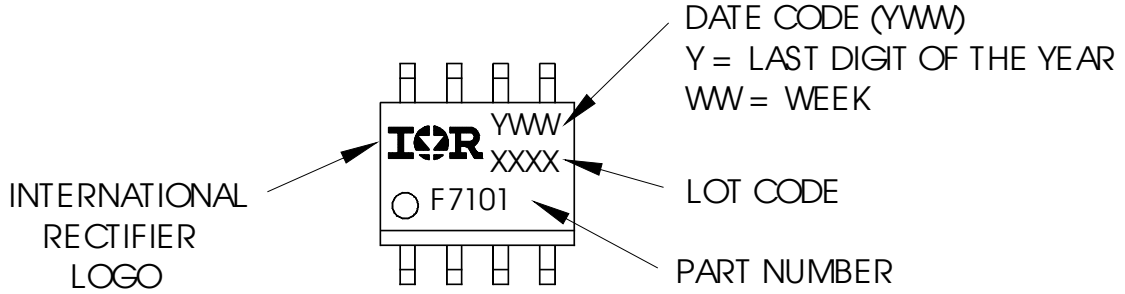
RECOMMENDED FOOTPRINT



Part Marking Information

SO-8

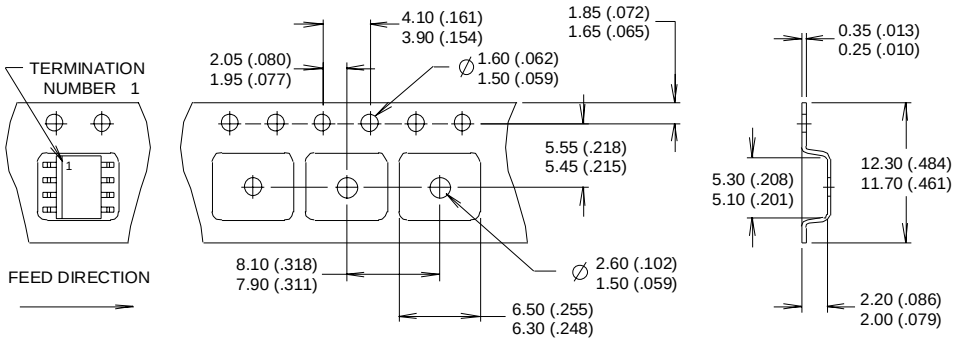
EXAMPLE: THIS IS AN IRF7101 (MOSFET)

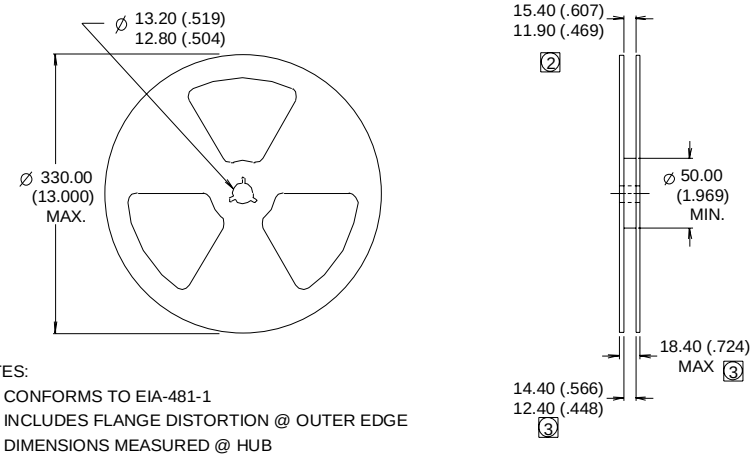


Tape & Reel Information

SO-8

Dimensions are shown in millimeters (inches)





NOTES:

1 CONFORMS TO EIA-481-1

2 INCLUDES FLANGE DISTORTION @ OUTER EDGE

3 DIMENSIONS MEASURED @ HUB

4 CONTROLLING DIMENSION : METRIC

Data and specifications subject to change without notice.

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